

Client

GRG METROLOGY&TEST

Certificate No: **24J02Z000193**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN : 7716**

Calibration Procedure(s) **FF-Z11-004-02**
Calibration Procedures for Dosimetric E-field Probes

Calibration date: **May 13, 2024**

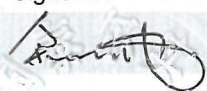
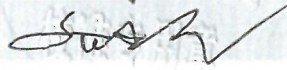
This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	106277	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Power sensor NRP8S	104291	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Power sensor NRP8S	104292	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Reference 10dBAttenuator	18N50W-10dB	19-Jan-23(CTTL, No.J23X00212)	Jan-25
Reference 20dBAttenuator	18N50W-20dB	19-Jan-23(CTTL, No.J23X00211)	Jan-25
Reference Probe EX3DV4	SN 7464	22-Jan-24(SPEAG, No.EX-7464_Jan24)	Jan-25
DAE4	SN 1555	24-Aug-23(SPEAG, No.DAE4-1555_Aug23)	Aug-24

Secondary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
SignalGenerator MG3700A	6201052605	12-Jun-23(CTTL, No.J23X05434)	Jun-24
SignalGenerator APSIN26G	181-33A6D0700-1959	26-Mar-24(CTTL, No.24J02X002468)	Mar-25
Network Analyzer E5071C	MY46110673	25-Dec-23(CTTL, No.J23X13425)	Dec-24
Reference 10dBAttenuator	BT0520	11-May-23(CTTL, No.J23X04061)	May-25
Reference 20dBAttenuator	BT0267	11-May-23(CTTL, No.J23X04062)	May-25
OCP DAK-12	SN 1174	25-Oct-23(SPEAG, No.OCP-DAK12-1174_Oct23)	Oct-24

	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: May 15, 2024

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



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Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i $\theta=0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- IEC 62209-1, "Measurement procedure for the assessment of Specific Absorption Rate (SAR) from hand-held and body-mounted devices used next to the ear (frequency range of 300 MHz to 6 GHz)", July 2016
- IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\theta=0$ ($f \leq 900\text{MHz}$ in TEM-cell; $f > 1800\text{MHz}$: waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR:** PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}:** A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800\text{MHz}$) and inside waveguide using analytical field distributions based on power measurements for $f > 800\text{MHz}$. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from $\pm 50\text{MHz}$ to $\pm 100\text{MHz}$.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle:** The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7716

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm($\mu V/(V/m)^2$) ^A	0.55	0.64	0.70	±10.0%
DCP(mV) ^B	108.1	108.7	106.5	

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu V}$	C	D dB	VR mV	Max Dev.	Max Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	190.9	±2.2%	±4.7%
		Y	0.0	0.0	1.0		208.0		
		Z	0.0	0.0	1.0		217.4		
10352-AAA	Pulse Waveform (200Hz, 10%)	X	1.43	60.42	6.80	10.00	60	±2.8%	±9.6%
		Y	1.56	60.91	6.69		60		
		Z	1.73	61.54	6.92		60		
10353-AAA	Pulse Waveform (200Hz, 20%)	X	0.83	60.00	5.60	6.99	80	±2.5%	±9.6%
		Y	22.00	78.00	11.00		80		
		Z	0.83	60.00	4.94		80		
10354-AAA	Pulse Waveform (200Hz, 40%)	X	4.00	68.00	7.00	3.98	95	±2.9%	±9.6%
		Y	62.00	78.00	9.00		95		
		Z	0.09	123.35	1.46		95		
10355-AAA	Pulse Waveform (200Hz, 60%)	X	0.31	60.00	4.06	2.22	120	±1.5%	±9.6%
		Y	0.28	60.00	3.47		120		
		Z	0.46	60.00	2.54		120		
10387-AAA	QPSK Waveform, 1 MHz	X	0.54	60.00	8.20	1.00	150	±3.8%	±9.6%
		Y	0.50	60.00	8.20		150		
		Z	0.57	60.00	8.30		150		
10388-AAA	QPSK Waveform, 10 MHz	X	1.07	60.59	9.27	0.00	150	±1.0%	±9.6%
		Y	1.07	61.09	9.69		150		
		Z	1.19	61.41	10.26		150		
10396-AAA	64-QAM Waveform, 100 kHz	X	1.64	61.40	13.04	3.01	150	±1.6%	±9.6%
		Y	1.70	62.67	14.07		150		
		Z	1.71	62.68	15.18		150		
10414-AAA	WLAN CCDF, 64-QAM, 40MHz	X	3.62	64.25	13.40	0.00	150	±3.9%	±9.6%
		Y	3.65	64.66	13.75		150		
		Z	3.88	64.74	14.02		150		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.